

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
		09/815,670	Examiner <i>SM</i> 7-02 Quyen P. Leung	Art Unit 2828

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5923690	07-1999	Kume et al	372/46
	B	US-			
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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